

Notice of References Cited	Application/Control No. 10/754,013		Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Michael A. Newman		Art Unit 2624	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0150813	08-2004	Kim et al.	356/237.1
*	B	US-7,037,735	05-2006	Noguchi et al.	438/18
*	C	US-7,162,071	01-2007	Hung et al.	382/144
*	D	US-4,870,357	09-1989	Young et al.	324/770
*	E	US-7,065,239	06-2006	Maayah et al.	382/145
*	F	US-2003/0215129	11-2003	Yang et al.	382/149
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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